APPLICAL	BLE STAN	DARD			ICTO	DACE					
	OPERATING TEMPERATURE RANGE OPERATING HUMIDITY RANGE VOLTAGE		-55 °C TO +85 °	C (1) (2)		RAGE PERATU	IRE RANGE		-10 °C TO +60 °C	(3)	
RATING			RH 90 % MAX	(2) (4)	STO RAN		UMIDITY		RH 70 % MAX (3)	(4) (6)	
			CI.			RRENT		4.0			
			300 V DC/AC		TION	0		40)A (TEMPERATURE RISE	30°C I	MAX
				IFICA	HON	5					
ITEM		TEST METHOD				REQUIREMENTS				QT	Α
CONSTRU						,					,
		VISUAL AND WITH MEASURING INSTRUMENT				ACCOR	DING TO D	RAWI	NG	×	>
MARKING ELECTRIC CHARAC		CONFIRMED VISUALLY								×	>
			S				(E)			1	1
CONTACT RESISTANCE [EIA-364-23]		10 mA				2 m \(\Omega \text{MAX.}^{(5)} \) MATED WITH IT-PB-2S-DIRL**				×	
EIA-364-21]		500 V DC				1000 MΩ MIN.				×	-
VOLTAGE PROOF [EIA-364-20]		1000 V AC FOR 1 MINUTE				NO FLASHOVER OR BREAKDOWN.				×	-
	CAL CHAR										•
INSERTION		MEASURED WITH RESPECT TO APPLICABLE				INSERTION FORCE: 50 N MAX.					
WITHDRAWAL FORCES [EIA-364-13]		CONNECTORS				WITHDRAWAL FORCE: 3 N MIN.				×	-
MECHANICAL		100 TIMES INSERTION AND EXTRACTION				(mated with IT-PB-2S-DIRL**) (Î) CONTACT RESISTANCE: 2 m Ω MAX. (5)				1	1
OPERATION		TOO THEE HOLK HOW AND EXTRACTION				② NO DAMAGE, CRACKS, OR LOOSE PARTS				×	-
[EIA-364-09]											
RANDOM VII	BRATION	FREQUENCY: 50 TO 2000 Hz				① NO ELECTRICAL DISCONTINUITY OF 1 μs OR					
[EIA-364-28]		POWER SPECTRAL DENSITY: 0.1 g²/Hz FOR 90 MINUTES IN THREE DIRECTIONS * Spacers were used to maintain the distance between the PCB's during testing.				MORE ② NO DAMAGE, CRACKS, OR LOOSE PARTS				×	-
SHOCK			DURATION OF PULSE: 11 m	าร							1
[EIA-364-27]		18 TIMES TOTAL, 3 EACH DIRECTION, 3 AXIS * Spacers were used to maintain the distance between the PCB's during testing.								×	-
FNVIRONI	MENTAL C										
THERMAL SI			URE: -55 →20 ~ 35 → 85 →20	0 ~ 35 °C		① CON	ITACT RES	ISTAN	CE: 2 m Ω MAX. (5)		
[EIA-364-32]		TIME: $30 \rightarrow 5 \text{ MAX} \rightarrow 30 \rightarrow 5 \text{ MAX}$ minutes 10 CYCLES				② INSULATION RESISTANCE : 100 MΩ MIN. ③ NO DAMAGE, CRACKS, OR LOOSE PARTS					
CYCLIC TEMPERATURE AND HUMIDITY [EIA-364-31]		@ 25 °C, 80% RH: 60 MIN DWELL TIME 30 MIN RAMP TIME @ 65 °C, 50% RH: 60 MIN DWELL TIME 24 CYCLES				×					-
DRY HEAT						① CON	ITACT RES	ISTAN	CF : 2 m O MAY (5)		+-
[EIA-364-17]		LAI-OSED A	EXPOSED AT 105 °C, 120 hr			① CONTACT RESISTANCE: 2 mΩ MAX. (5) ② NO DAMAGE, CRACKS, OR LOOSE PARTS				×	
MIXED FLOWING GAS		EXPOSED AT 30 °C, 70%				CONTACT RESISTANCE : 2 m Ω MAX. ⁽⁵⁾					t
[EIA-364-65]			$_2$: 10 ppb, NO $_2$: 200 ppb, H $_2$ S : 10 ppb, SO $_2$: 100 ppb NMATED 7 DAYS, MATED 7 DAYS							×	-
	COUNT DESCRIPTION		ON OF REVISIONS DESIG			NED CHECKED			CHECKED	DA	TE
<u>/</u>											
REMARKS (1) INCLUDE TEMPERATURE RISE CAUSED BY CURRENT-CARRYING.							APPROV	ED MK. EZAKI		15 1	2 0
(2) OPERATING (3) "STORAGE"	TEMPERATURE MEANS A LONG-	SHOULD BE -5 TERM STORAG	HOULD BE -55 TO 55 $^{\circ}$ C WHEN HUMIDITY EXCEEDS 80% RH. ERM STORAGE STATE FOR THE UNUSED PRODUCT IN SEALED BA						MK. EZAKI	15. 12. 03 15. 12. 03	
(4) NO DEW CO (5) THE VALUE		PERMITTED. SISTANCE INC				NCE. DECICNED				NY. SHIMURA 15.	
SULFUR, AN	ID CHLORIDE WH	HICH CAN CAUS						N			2.0
Note; QT:Qualification Test AT:Assu			urance Test X:Applicable Test DI			L RAWING NO.		+	ELC-364206-11-00		
RS SPECIFICATION SHEET PA					PART	NO.		ΙT	IT-PB-2P-11H(11)		
	HIE	OSF FL	ECTRIC CO., LTD.		CODE	NO.	CL6	636-	0633-0-11	\Diamond	1/